

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/004,805	SHIMIZU ET AL.
	Examiner A. Sefer	Art Unit 2826

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
349	155-158	6/2/2006	AS
	162	6/2/2006	AS